

10/577354

IAP12 Rec'd PCT/PTO 28 APR 2006

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re the Application of

Paul Alexander DE VRIES et al.

Application No.: To be assigned (National Phase of PCT/EP2004/012836 filed November 10, 2004)

Filed: April 28, 2006

For: METHOD OF COOLING MOLTEN METAL DURING FRACTIONAL CRYSTALLISATION

**INFORMATION DISCLOSURE STATEMENT**

Mail Stop Patent Application  
Commissioner for Patents  
P.O. Box 1450  
Alexandria, VA 22313-1450

Sir:

Pursuant to Rules 56 and 98, Applicants hereby call the attention of the Patent Office to the references listed on the attached Form PTO 1449. These references were cited in an International Search Report (copy enclosed) in a corresponding International Application.

Applicants present these references so that the Patent Office may, in the first instance, determine any relevancy thereof to the presently claimed invention, see Beckman Instruments, Inc. v. Chemtronics, Inc., 439 F.2d 1369, 1380, 165 USPQ 355, 364 (5th Cir. 1970). Also see Patent Office Rule 104. Applicants respectfully request that these references be expressly considered during the prosecution of this application and made of record herein and appear among the "Reference Cited" on any patent to issue herefrom.

Respectfully submitted,

Date: April 28, 2006 By: Anthony P. Venturino  
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FORM PTO-1449 U.S. Department of Commerce (Rev. 4/92) Patent and Trademark Office	ATTY. DOCKET NO. <b>APV31929</b>	APPLICATION NO. <b>10/1577354</b> To be assigned
<b>INFORMATION DISCLOSURE STATEMENT BY APPLICANT</b> <hr/> (Use several sheets if necessary)		
<b>APPLICANT</b> <b>Paul Alexander DE VRIES et al.</b>		<b>GROUP</b>
<b>FILING DATE</b> <b>April 28, 2006</b>		

## **U.S. PATENT DOCUMENTS**

EXAMINER INITIAL	DOCUMENT NUMBER							DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
	3	2	1	1	5	4	7	10/65	N. Jarrett et al.			
	4	2	7	3	6	2	7	06/81	Dawless et al.			

## **FOREIGN PATENT DOCUMENTS**

**OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)**

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**EXAMINER**

**DATE CONSIDERED**

**EXAMINER:** Initial if citation is considered, draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.